

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







PRODUCT SPECIFICATION Title: USB Type C to USB 3.1 Legacy Cable Assy

		TITLE : USB	Type C to USB 3.1	Legacy Cable	Assy		
A Initial Release THIS DOCUMENT CONTAINS INFORMATIOON THAT IS PROPRIETARY TO							
REV.	DESCRIPTION	MOLEX AND SHOU	MOLEX AND SHOULD NOT BE USED WITHOUT WRITTEN PERMISSION				
DOCUMENT NO.		Prepared By:	LUCY LI		Date:	15/10/11	Sheet No.
PS-68798-0007		Checked By:	LUCY LI		Date :	15/10/11	
		Approved By:	NIE FRED		Date :	15/10/11	1 OF 6

DONGGUAN MOLEX INTERCONNECT.,LTD

1 Scope

This specification covers the requirements for USB Type C to USB 3.1 Legacy Cable Assy

2 Product Description

USB Type C to USB 3.1 Legacy Cable Assy

See the sales drawing and the other section of this specification for the necessary. In cases where the specification differs from the drawings, the sales drawings take precedence.

3 Ratings

Voltage

Rated Voltage: 30V DC

Current

Vbus and GND, refer to sales drawing

Current of 0.25A shall be applied to all the other contacts.

4 Temperature

Operating temperature: -10 °C to +50 °C

Storage temperature: -20 °C to +60 °C

5. Pin assignment

See sales drawing

		TITLE : USB -	Гуре C to USB 3.1 Legacy Cable	Δeev			
		OSB Type C to OSB 3.1 Legacy Cable Assy					
A Initial Release THIS DOCUMENT CONTAINS INFORMATIOON THAT IS PROPRIETARY TO							
REV.	DESCRIPTION	MOLEX AND SHOULD NOT BE USED WITHOUT WRITTEN PERMISSION					
DOCUMENT NO.		Prepared By:	LUCY LI	Date :	15/10/11	Sheet No.	
I PS-68/98-000/		Checked By:	LUCY LI	Date :	15/10/11		
		Approved By:	NIE FRED	Date :	15/10/11	2 OF 6	

DONGGUAN MOLEX INTERCONNECT.,LTD

6. Electrical And Signal Inte	egrity Compliance Requirements				
Test Description	Test Condition Performance Requirement	ent			
Low Level Contact Resistance (LLCR)	EIA 364-23 The low level contact resistance (LLCR) measurement is made across the plug and receptacle mated contacts and does not include any internal paddle cards or substrates of the plug or receptacle. The test boards shall be provided with the connectors to be tested. • Measure at 20 mV (max) open circuit at 100 mA. The following requirements apply to the pow contacts: Type C plug:40 mΩ (max) initial for VBUS, 0 contacts.50 mΩ maximum after initial measurements apply to the pow contacts: Type C plug:40 mΩ (max) initial for VBUS, 0 contacts.50 mΩ maximum after initial measurement and Ground (GND) contacts and 50 mΩ maximum change (delta) of the environmental stresses	er and signal GND and all other urement. or the Power (VBUS) kimum initial for all			
Dielectric Withstanding Voltage	Test voltage 100 VAC, 1Min. No breakdown				
Cable Assembly Voltage Drop	The maximum rated VBUS current of the cable assembly shall be used. The measurement includes representative receptacles at both ends of the cable assembly, mounted on test fixtures. 250 mV max for GND and 500 mV max for N	/BUS.			
D+/D- Pair Differential Impedance	Refer to appendix G.4 of Type C connectors and cable assemblies compliance document Measured with a 400 ps rise time (20%-80%).				
D+/D- Pair Propagation Delay	Refer to appendix G.4 of Type C connectors and cable assemblies compliance document Use a 400 ps rise time (20%-80%) at 50% voltage crossing. 10 ns max for USB Type-C to Micro-B cable 20 ns max for all other USB Type-C to legac assemblies.				
D+/D- Pair Intra-pair Skew	Refer to appendix G.4 of Type C connectors and cable assemblies compliance document 100 ps max.	100 ps max.			
D+/D- Pair Attenuation	Refer to appendix G.4 of Type C connectors and cable assemblies compliance document	≥ -1.43 dB @ 100 MHz≥ -2.40 dB @ 200 MHz			
VBUS Capacitance	Refer to appendix G.5 of Type C connectors and cable assemblies compliance document 8 nF to 12 nF located in the Type-C plug.				
Rd resistor verification	Measure the resistance between pin A5 and Ground (pin A1, A12, B1, or B12). Type-C pin A5 resistance to GND for cable a B plug.	assemblies with a USB			
Rp resistor verification	Measure the resistance between pin A5 and VBUS (pin A4, A9, B4, or B9). Type-C pin A5 to VBUS resistance for cable Standard-A plug.	Type-C pin A5 to VBUS resistance for cable assemblies with a Standard-A plug.			
TITLE : USB Type C to USB 3.1 Legacy Cable Assy					
==:/	IIS DOCUMENT CONTAINS INFORMATIOON THAT IS PROPRIETARY TO DLEX AND SHOULD NOT BE USED WITHOUT WRITTEN PERMISSION				
	epared By: LUCY LI Date: 15/10/11	Sheet No.			
PS-68798-0007	necked By: LUCY LI Date: 15/10/11	3 OE 6			
Ap	oproved By: NIE FRED Date: 15/10/11	3 OF 6			

DONGGUAN MOLEX INTERCONNECT.,LTD)

Test Description	Test Condition	Performance Requirement
Differential Insertion Loss Fit at Nyquist Frequencies (ILfitatNq)	Refer to appendix G.3 of Type C connectors and cable assemblies compliance document	≥ -4 dB @ 2.5 GHz, except for the USB Type-C plug to USB 3.1 Standard-A plug cable assembly which is: ≥ -3.5 dB @ 2.5 GHz ≥ -6 dB at 5 GHz
Integrated Differential Multi- reflection (IMR)	Refer to appendix G.3 of Type C connectors and cable assemblies compliance document	≤ 0.126 · ILfitatNq^2+3.024 · ILfitatNq − 21.392 (in dB). For SuperSpeed pairs only.
Integrated Differential Crosstalk on SuperSpeed (ISSXT)	Refer to appendix G.3 of Type C connectors and cable assemblies compliance document	≤ -38dB
Integrated Differential Crosstalk on D+/D- (IDDXT)	Refer to appendix G.3 of Type C connectors and cable assemblies compliance document	≤ -28.5 dB
Integrated Return Loss (IRL)	Refer to appendix G.3 of Type C connectors and cable assemblies compliance document	≤ 0.046· ILfitatNq^2 + 1.812 · ILfitatNq − 9.784 (in dB). For SuperSpeed pairs only.
Differential-to -Common-Mode Conversion (SCD12 and SCD21)	Refer to appendix G.3 of Type C connectors and cable assemblies compliance document	≤ -20 dB from 100 MHz to 10 GHz.

		TITLE: USB	Type C to USB 3.1 Legacy Cable	Assy			
Α	Initial Release	THIS DOCUMENT C	IS DOCUMENT CONTAINS INFORMATIOON THAT IS PROPRIETARY TO				
REV.	DESCRIPTION	MOLEX AND SHOULD NOT BE USED WITHOUT WRITTEN PERMISSION					
DOCUMENT NO.		Prepared By:	LUCY LI	Date :	15/10/11	Sheet No.	
I PS-68798-0007		Checked By:	LUCY LI	Date :	15/10/11]	
		Approved By:	NIE FRED	Date :	15/10/11	4 OF 6	

DONGGUAN MOLEX INTERCONNECT.,LTD

7. Mechanical Compliance Requirements

Approved By:

NIE FRED

15/10/11

Date:

5 OF 6

7. Mechanicai C	ompliai	nce Requirements				
Test Description		Test Condition			Performance Requi	rement
Cable Flexing 3.7 time		4-41, Condition I with Dimension X = es the cable diameter and 100 cycles of two planes 120 degree arc.		No physical damage and discontinuity over 1 microsecond during flexing shall occur to the cable a		
Cable Pull-Out The cat a minim		4-38 Test Condition A ble assembly shall is subjected to a 40N axial load for num of 1 minute lamping one end of the cable plug.		tinuity over 1	damage and no elect microsecond to the	
4-Axes Continuity	assem Plug ar interfact for at le	Type C:Refer to appendix D of Type C connectors and cable assemblies compliance document. Plug and Receptacle: Subject the mating interface to the moments defined in Appendix D for at least 10 seconds. USB 3.1 Micro Connector Family Only: Refer to 5.7.1.7 of USB 3.1 standard		No discontinuities greater than 1 microsecond duration in any of the four orientations tested.		
Insertion Force	EIA 364-13 The insertion force test shall be done at a maximum rate of 12.5 mm (0.492") per minute.			USB Type C: Within the range from 5 N to 20 N. USB 3.1 Type A and B:35 Newtons maximum		
Extraction Force	EIA 364-13 The extraction force test shall be done at a maximum rate of 12.5 mm (0.492") per minute.		USB Type C:Within the range of 8 N to 20 N, measured after a preconditioning of five insertion/extraction cycles (i.e., the sixth extraction). After an additional twenty-five insertion/extraction cycles, the extraction force shall be measured again (i.e., the thirty second extraction) and the extraction force shall be within: a) 33 % of the initial reading, and b) within the range of 8 N to 20 N. The extraction force shall be within the range of 6 N to 20 N after 10,000 insertion/extraction cycles. USB 3.1 Type A and B:The connector extraction force shall not be less than 10 N initial and 8 N after the specified insertion/extraction or durability cycles. Micro Connector Family Only:The connector extraction force shall not be less than 10 N or more than 25 N initial and less than 8 N and more than 25 N after the specified insertion/extraction or durability cycles No burs or sharp edges are allowed on top of locking latches (hoo surfaces that will rub against the receptacle shield).			
Durability or Insertion/Extraction Cycles	EIA 364-09		USB Type C:10,000 cycles minimum. USB 3.1 Standard-A, Standard-B and Powered-B series: Standard Durability Class:1500 cycles High Durability Class: 5000 cycles USB 3.1 Micro Connector Family:10,000 cycles Conductor resistance and dielectric withstanding voltage shall be checked to be within spec after the durability cycles			
	-		CHECK	OG TO DE WILLIN	opec and the dula	omy cyclos
		TITLE : USB Type C to USB 3.1 Legac	y Cable	e Assy		
A Initial Re		THIS DOCUMENT CONTAINS INFORMATIOON THAT IS				
REV. DESCRI		MOLEX AND SHOULD NOT BE USED WITHOUT WRITTEN		Date :	15/10/11	Sheet No.
POCOMENT IN	J.	Prepared By: LUCY LI Checked By: LUCY LI			15/10/11	Stieet No.
PS-68798-0	007	Checked By: LUCY LI		Date :	15/10/11	5 OE 6

	DONGGUAN MOLEX INTER	CONNECT.,LTD				
Wrenching Strength (Plug-only)	Type C: Perpendicular forces are applied to the plug in four directions (i.e., left, right, up, and down). A metal fixture with opening and tongue representative of a receptacle shall be used. Refer to Appendix E of Type C connectors and cable assemblies compliance document USB 3.1 Micro Connector Family Only: Refer to 5.7.1.8 of USB 3.1 standard	Type C: A single plug shall be used for this test. Some mechanical deformation may occur. The plug shall be mated with the continuity test fixture after the test forces have been applied to verify no damage has occurred that causes discontinuity or shorting. The Dielectric Withstanding Voltage test shall be conducted after the continuity test to verify plug compliance. A new plug is required for each of the four test directions. The plug shall disengage from the test fixture or demonstrate mechanical failure (i.e., the force applied during the test procedure peaks and drops off) when a moment of 2.0 Nm is applied to the plug in the left and right directions. USB 3.1 Micro Connector Family Only: The wrenching strength test shall be performed using virgin parts. Perpendicular forces (Fp) are applied to a plug when inserted at a distance (L) of 15 mm from the edge of the receptacle. Testing conditions and method shall be agreed to by all parties. These forces shall be applied in all four directions (i.e., left, right, up, and down). Compliant connectors shall meet the following force thresholds: No plug or receptacle damage shall occur when a force of 0-25 N is applied. The plug may be damaged, but only in such a way that the receptacle does not sustain damage when a force of 25-50 N is applied.				
8. Environmenta	I Compliance Requirements					
Test Description	Test Procedure	Performance Requirement				
Temperature Life	EIA 364-17, Method A. 105° C without applied voltage for 120 hours. 105° C without applied voltage for 72 hours when used as preconditioning. The object of this test procedure is to detail a standard method to assess the ability of a USB connector to withstand temperature.	Conductor resistance meets spec before and after the Temperature Life test.				
Cyclic Temperature and Humidity	EIA 364-31 The object of this test procedure is to detail a standard test method for the evaluation of the designs and materials used in USB connectors as the effects of high humidity and heat influences them.	Subject samples to between 25°C±3°C at 80%±3% RH and 65°C±3°C at 50%±3% RH,Ramp times should be 0.5 hour and dwel times should be 1.0hour.Dwell times start when the temperature and humidity have stabilized within the specified levels.Perform 24 such cycles. Conductor resistance meets spec before and after the Cyclic Temperature and Humidity test.				
	ly Shielding Effectiveness Compliance Requirements	Performance Requirement				
Test Description Cable Shielding Effectiveness	Test Procedure USB Type-C connectors and cable assemblies compliance document	Differential model: \leqslant -49 dB for f \leqslant 1.6 GHz \leqslant -44 dB for 1.6 GHz \leqslant f \leqslant 4GHz and 5 GHz \leqslant f \leqslant 6 GHz Common model: \leqslant -34 dB for f \leqslant 1.6 GHz \leqslant f \leqslant 4 GHz and 5 GHz \leqslant f \leqslant 6 GHz				
	TITLE : USB Type C to USB 3.1 Legacy					
A Initial Re						
DOCUMENT NO	D. Prepared By: LUCY LI Checked By: LUCY LI	Date : 15/10/11 Sheet No.				
PS-68798-0	Approved By: NIE FRED	Date: 15/10/11 6 OF 6				